

700V GaN FET

**Datasheet
Preliminary**

1. Description

The G2N70 series FETs are hybrid normally-off Gallium Nitride (GaN) field effect transistors with the strongest gate and the lowest reverse voltage drop of all wide-band-gap devices in the market. They allow simple gate drive, offer best-in-class performance and outstanding reliability.

Features

- Reduced voltage stress of secondary-side synchronous rectifier.
- Optimized turn-on/off speed for EMI performance.
- Threshold voltage designed for 6V driver.
- Strong gate with a high repetitive input voltage tolerance of $\pm 20V$.
- Low Q_g and simple gate drive for lowest driver consumption at high frequencies.
- Lowest V_F in off-state reverse conduction among all SiC and GaN FETs for low loss during dead-times.
- Negligible Q_{rr} for outstanding hard-switched bridge applications.
- High spike tolerance of 800V for enhanced reliability.

Benefits

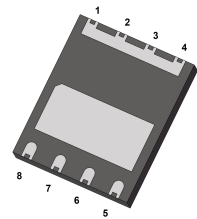
- Enable very high conversion efficiencies.
- Enable higher frequency for compact power supplies.
- End-product cost & size savings due to reduced cooling requirements.
- Improved safety & reliability due to cooler operation temperature.

Applications

- High-frequency compact chargers with QR or ACF flyback topologies.
- Other ZVS or CRM topologies.

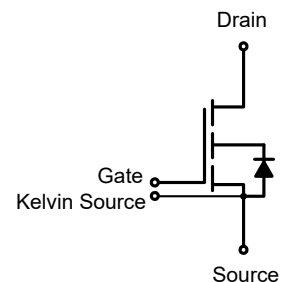


Top View



Bottom View

Drain	1, 2, 3, 4
Source	5, 6, Tab
Kelvin Source	7
Gate	8



Schematic Symbol

Key Performance Parameters	
V_{DSS} (V)	700
$V_{DSS(PK)}$ (V) ^{a)}	800
$R_{DS(on), typ}$ (m Ω) ^{b)}	240
Q_{oss} (nC)	22
Q_g (nC)	4.9

^{a)} Duty cycle < 1%, spike duration < 30 μ s, repetitive for $\leq 85^\circ C$, non-repetitive up to $150^\circ C$

^{b)} Dynamic on-resistance



Part Number & Package Information

Part #	Package	Package Base
G2N70R240PC-LS	DFN 5x6 (mm)	Source

2. Maximum Ratings

Symbol	Parameter	Value
V_{DSS} (V)	Drain-source maximum voltage ($T_J = -55^{\circ}\text{C}$ to 150°C)	700
$V_{DSS(PK)}$ (V)	Drain-source maximum peak voltage ^{a)}	800
V_{GSS} (V)	Gate-source maximum voltage	± 20
P_D (W)	Maximum power dissipation ($T_C = 25^{\circ}\text{C}$)	27
I_{DS} (A)	Maximum continuous drain current ($T_C = 25^{\circ}\text{C}$)	7.2
	Maximum continuous drain current ($T_C = 100^{\circ}\text{C}$)	4.5
$I_{DS(pulse)}$ (A)	Maximum pulsed drain current ($T_C = 25^{\circ}\text{C}$) ^{b)}	30
T_J ($^{\circ}\text{C}$)	Operating junction temperature	-55 to 150
T_S ($^{\circ}\text{C}$)	Storage temperature	-55 to 150
T_{sold} ($^{\circ}\text{C}$)	Reflow soldering temperature ^{c)}	260

^{a)} Duty cycle < 1%, spike duration < 30 μs , repetitive for $\leq 85^{\circ}\text{C}$, non-repetitive up to 150°C

^{b)} Pulse width = 10 μs

^{c)} Reflow MSL3

3. Thermal Characteristics

Symbol	Parameter	Typ.
R_{thJC} ($^{\circ}\text{C}/\text{W}$)	Junction-to-case thermal resistance	4.7
R_{thJA} ($^{\circ}\text{C}/\text{W}$)	Junction-to-ambient thermal resistance ^{a)}	50

^{a)} Soldered on a PCB of 6cm² metal area

4. Device Characteristics

$T_J = 25^\circ\text{C}$ unless specified

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
$V_{GS(th)}$	Gate threshold voltage	1.4	1.8	2.4	V	$V_{DS} = V_{GS}$, $I_D = 0.5\text{mA}$
$R_{DS(on)}$	Drain-source on resistance ^{a)}	-	240	312	m Ω	$V_{GS} = 6\text{V}$, $I_D = 5\text{A}$
		-	520	-	m Ω	$V_{GS} = 6\text{V}$, $I_D = 5\text{A}$, $T_J = 150^\circ\text{C}$
I_{DSS}	Drain-source leakage current	-	-	2	μA	$V_{DS} = 700\text{V}$, $V_{GS} = 0\text{V}$
		-	2	-	μA	$V_{DS} = 700\text{V}$, $V_{GS} = 0\text{V}$, $T_J = 150^\circ\text{C}$
I_{GSS}	Gate-source leakage current	-100	-	100	nA	$V_{GS} = \pm 20\text{V}$
C_{iss}	Input capacitance	-	518	-	pF	$V_{GS} = 0\text{V}$, $V_{DS} = 400\text{V}$, $f = 500\text{kHz}$
C_{oss}	Output capacitance	-	16	-	pF	$V_{GS} = 0\text{V}$, $V_{DS} = 400\text{V}$, $f = 500\text{kHz}$
C_{rss}	Reverse transfer capacitance	-	0.2	-	pF	$V_{GS} = 0\text{V}$, $V_{DS} = 400\text{V}$, $f = 500\text{kHz}$
$C_{o(er)}$	Equivalent output capacitance (energy related)	-	24	-	pF	$V_{GS} = 0\text{V}$, $V_{DS} = 0\text{V to } 400\text{V}$
$C_{o(tr)}$	Equivalent output capacitance (time related)	-	54	-	pF	$V_{GS} = 0\text{V}$, $V_{DS} = 0\text{V to } 400\text{V}$
Q_g	Gate charge total	-	4.9	-	nC	$V_{DS} = 400\text{V}$, $V_{GS} = 0\text{V to } 6\text{V}$, $I_D = 5\text{A}$
Q_{gs}	Gate to source charge	-	1.4	-	nC	$V_{DS} = 400\text{V}$, $V_{GS} = 0\text{V to } 6\text{V}$, $I_D = 5\text{A}$
Q_{gd}	Gate to drain charge	-	1.4	-	nC	$V_{DS} = 400\text{V}$, $V_{GS} = 0\text{V to } 6\text{V}$, $I_D = 5\text{A}$
Q_{oss}	Output charge	-	22	-	nC	$V_{GS} = 0\text{V}$, $V_{DS} = 0\text{V to } 400\text{V}$
$t_{d(on)}$	Turn on delay time	-	26	-	ns	$V_{DS} = 400\text{V}$, $V_{GS} = 0\text{V to } 6\text{V}$, $I_D = 4\text{A}$, $R_{G-ON} = 22\Omega$, $R_{G-OFF} = 22\Omega$, $Z_{FB} = 120\Omega @ 100\text{MHz}$
t_r	Rise time	-	56	-	ns	
$t_{d(off)}$	Turn off delay time	-	31	-	ns	
t_f	Fall time	-	12	-	ns	

^{a)} Dynamic on-resistance

Reverse Device Characteristics , $T_J = 25^\circ\text{C}$ unless specified

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
I_S	Reverse current	-	-	5	A	$V_{GS} = 0V$, $T_C = 100^\circ\text{C}$, $\leq 50\%$ duty cycle
$I_S(\text{pulse})$	Pulsed reverse current	-	-	12	A	$V_{GS} = 0V$, $V_{SD} = 6V$, pulse width $\leq 10\mu\text{s}$, $T_J = 150^\circ\text{C}$
V_{SD}	Reverse voltage ^{a)}	-	1.7	-	V	$V_{GS} = 0V$, $I_S = 5A$
t_{rr}	Reverse recovery time	-	16.5	-	ns	$I_S = 4A$, $V_{DD} = 400V$, $di/dt = 1000A/\mu\text{s}$
Q_{rr}	Reverse recovery charge ^{b)}	-	0	-	nC	$I_S = 4A$, $V_{DD} = 400V$, $di/dt = 1000A/\mu\text{s}$

^{a)} Including the effect of dynamic on-resistance^{b)} Excluding Q_{oss}

5. Typical Characteristics ($T_c = 25^\circ\text{C}$ unless specified)

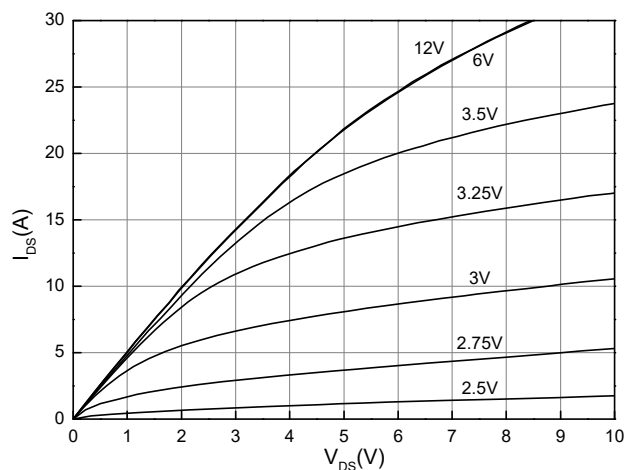


Figure 1. Typical Output Characteristics at $T_J = 25^\circ\text{C}$
(Parameter: V_{GS})

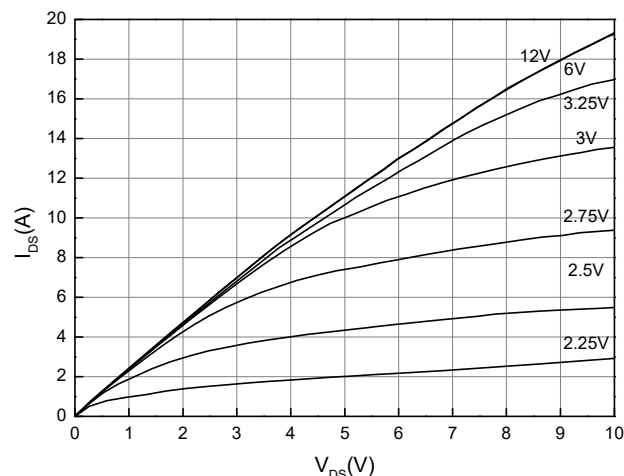


Figure 2. Typical Output Characteristics at $T_J = 150^\circ\text{C}$
(Parameter: V_{GS})

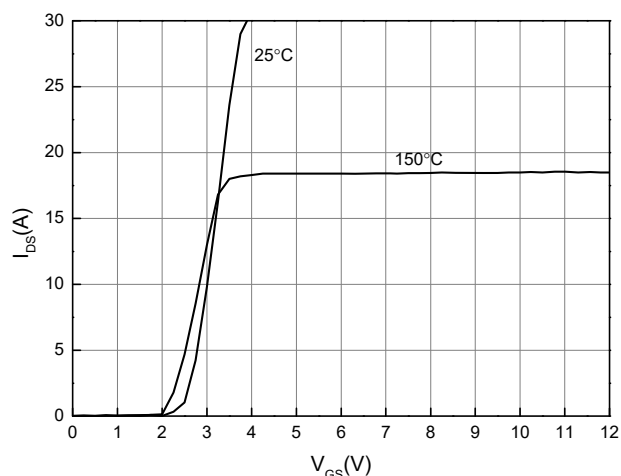


Figure 3. Typical Transfer Characteristics
($V_{DS} = 10\text{V}$, Parameter: T_J)

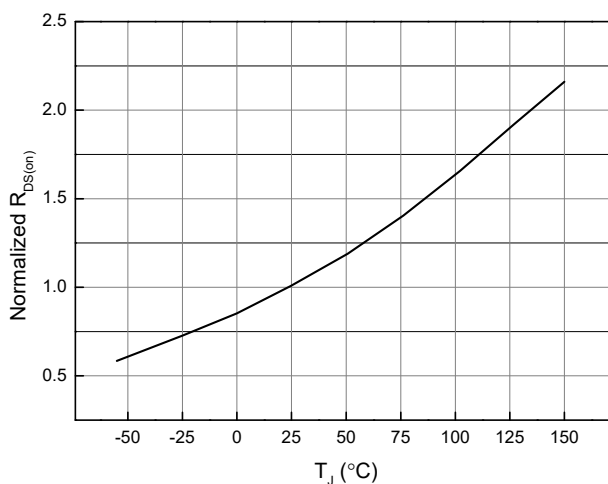


Figure 4. Normalized On-Resistance
($I_D = 5\text{A}$, $V_{GS} = 6\text{V}$)

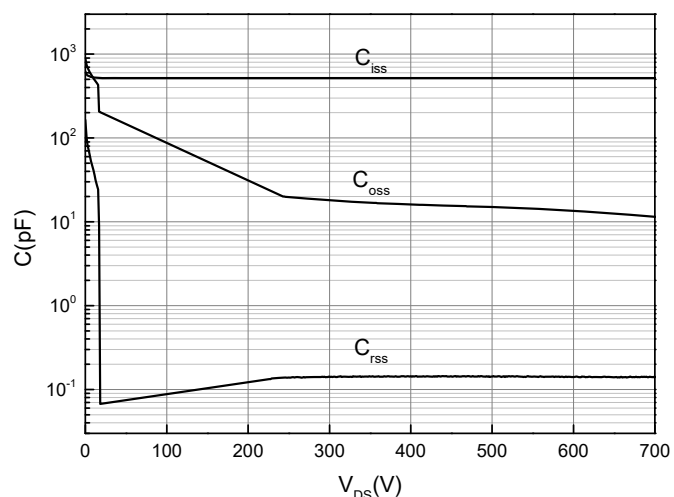


Figure 5. Typical Capacitance
($V_{GS} = 0V$, $f = 500kHz$)

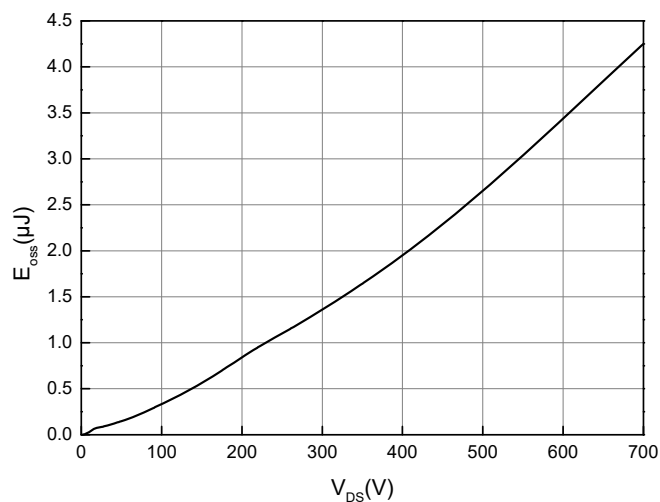


Figure 6. Typical C_{oss} Stored Energy

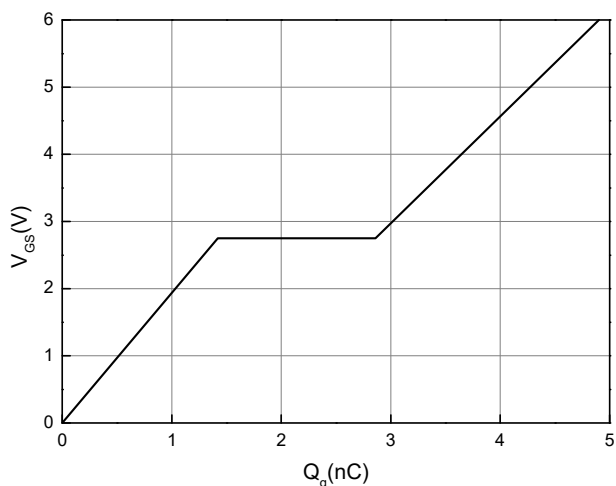


Figure 7. Typical Gate Charge
($I_{DS} = 5A$, $V_{DS} = 400V$)

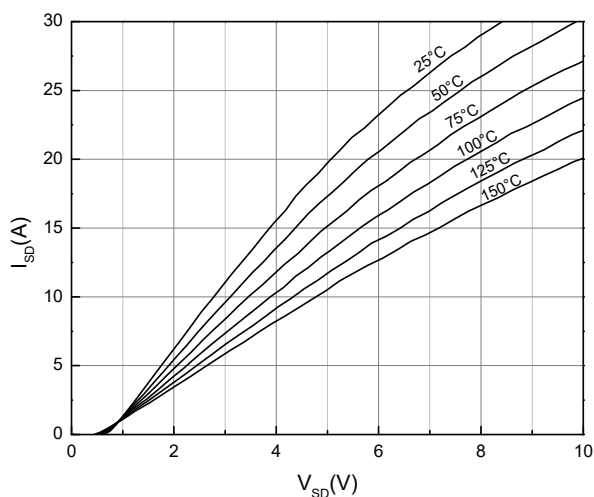


Figure 8. Reverse Conduction Characteristics
($-20V \leq V_{GS} \leq 0V$, Parameter: T_J)

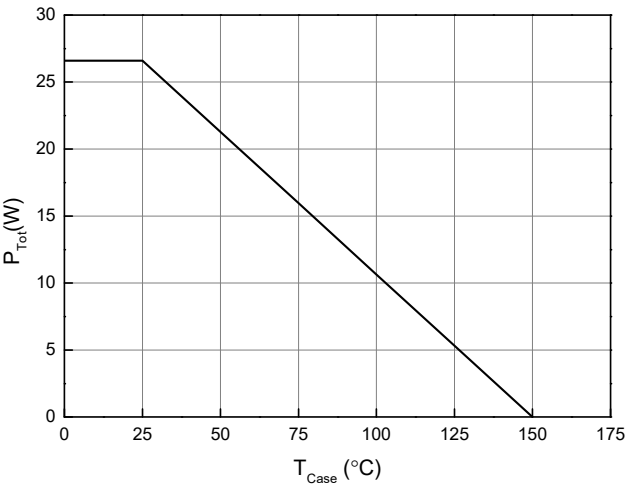


Figure 9. Power Dissipation

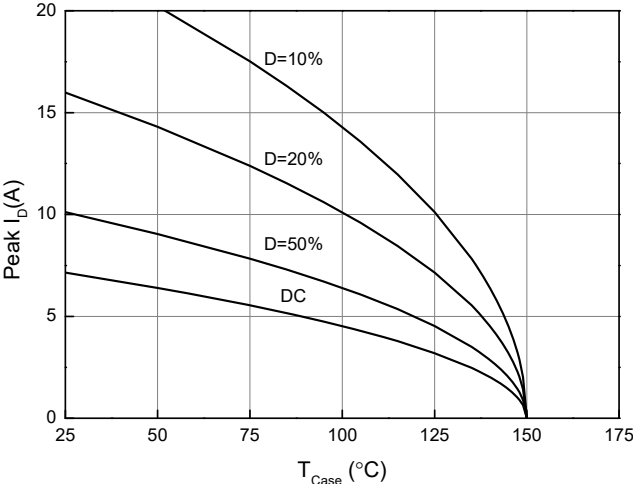


Figure 10. Current Derating
(Pulse Width $\leq 10\mu s$, $V_{GS} \geq 6V$)

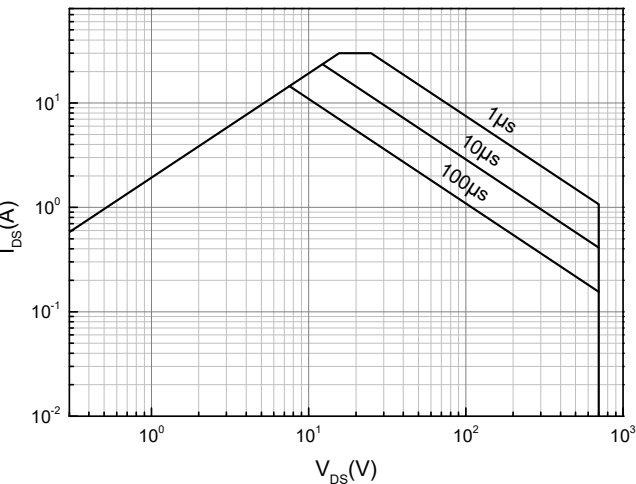


Figure 11. Safe Operating Area at $T_c = 25^\circ C$

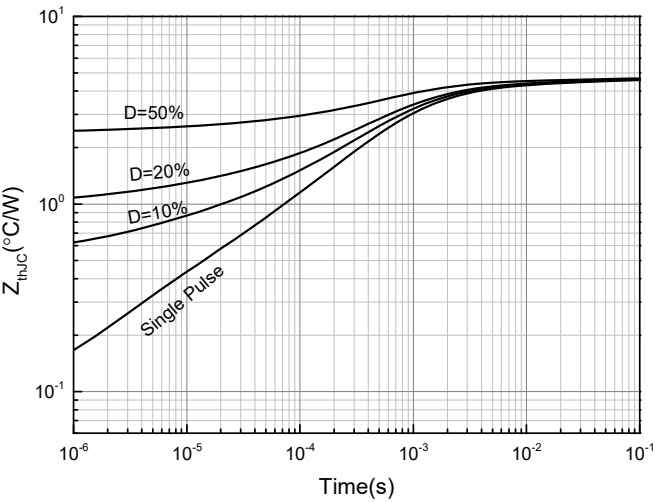


Figure 12. Transient Thermal Resistance

6. Design Considerations

The fast switching of GaN devices reduces current-voltage crossover losses and enables high frequency operation while simultaneously achieving high efficiency. However, taking full advantage of the fast switching characteristics of GaN switches requires adherence to specific PCB layout guidelines and probing techniques.

DO	DO NOT
Place gate driver close to the GaN device and separate input traces from output traces	Use long gate drive traces, long lead length and route the output traces next to the input
Use gate ferrite bead and dc-link RC snubber	Use close-by decoupling capacitor without series resistor
Minimize trace length of the PCB layout for both drive loop and power loop	Use a traditional differential voltage probe for V_{gs} of high side device

7. Circuit Implementation

Flyback Schematic

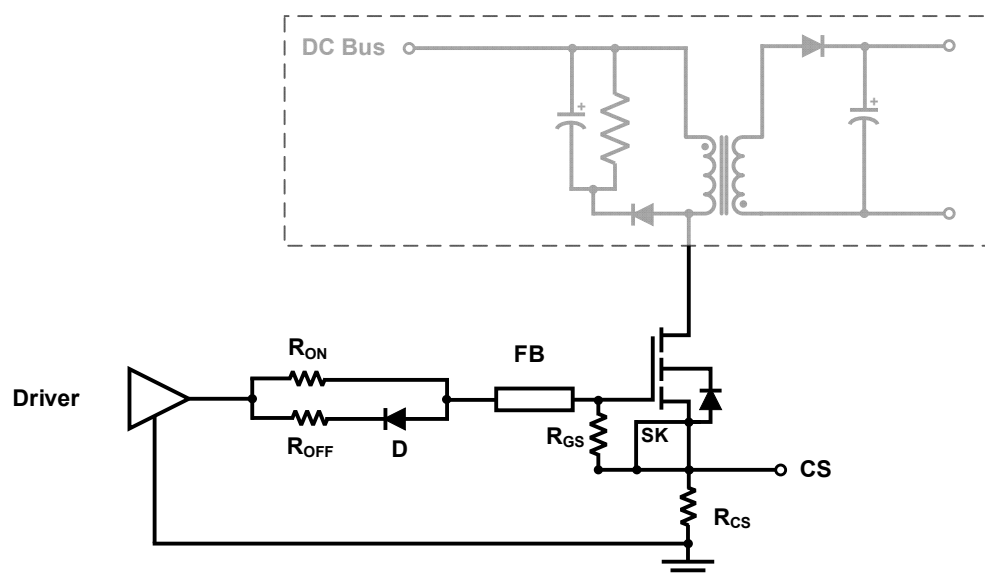
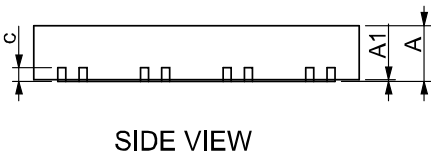
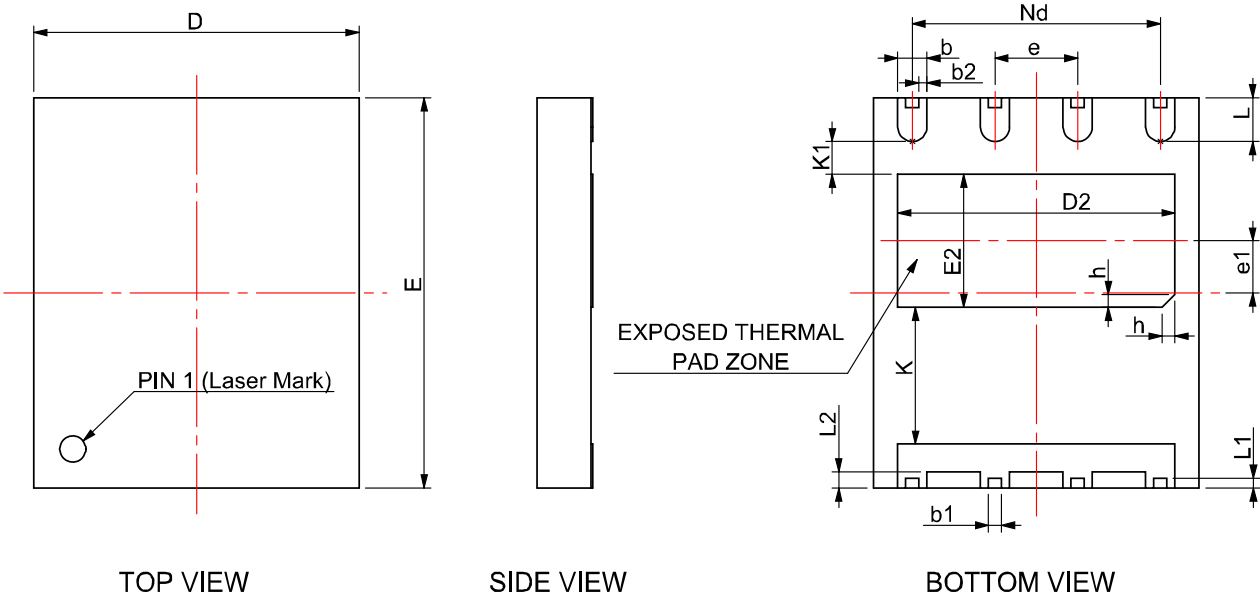


Figure 13. Simplified flyback schematic

Recommended gate drive: (0V, 6V)

Ferrite Bead (FB)	R_{ON}	R_{OFF}
0-120Ω @100MHz	100-300Ω	2-10Ω

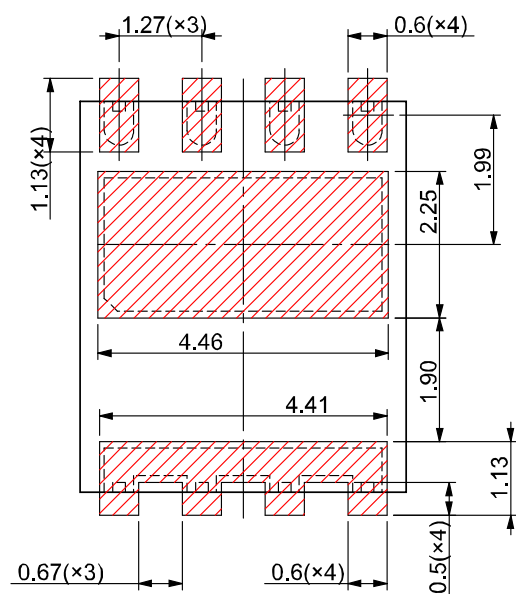
8. Package Dimensions



DIM.	Millimeters			DIM.	Millimeters		
	MIN.	NOM.	MAX.		MIN.	NOM.	MAX.
A	1.05	1.10	1.15	Nd	3.81BSC		
A1	0.00	0.02	0.05	E	5.90	6.00	6.10
b	0.40	0.45	0.50	E2	1.95	2.05	2.15
b1	0.20REF			L	0.625	0.675	0.725
b2	0.125REF			L1	0.15REF		
c	0.203REF			L2	0.25REF		
D	4.90	5.00	5.10	h	0.15	0.20	0.25
D2	4.16	4.26	4.36	K	2.10REF		
e	1.27BSC			K1	0.50REF		
e1	0.80BSC						
DFN 5 × 6							
GaNext							
Date : 2023.06				Rev.01			

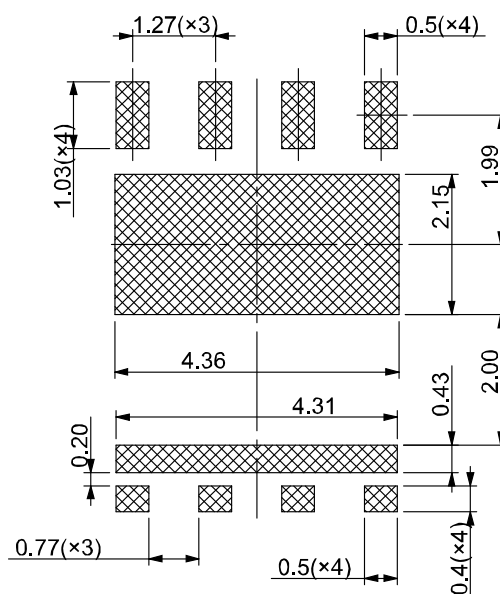
Lead Finish: Sn Plating

9. Recommended PCB Land Pattern



Footprint

TOP VIEW



Recommended stencil apertures
(Based on stencil thickness of 0.130mm)

TOP VIEW

10. Part Marking

